

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: November 26, 2003

ATTY DOCKET NO.
2003_1698A

SERIAL NO.

NEW

10/721164

APPLICANT
Etsuko NAKAMURA et al.FILING DATE
November 26, 2003

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ACW	AA	6,329,118	12/2001	Hussein et al.			
ACW	AB	5,981,145	11/1999	Ding et al.			
ACW	AC	5,994,430	11/1999	Ding et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
ACW	AJ	10-319601	12/1998	Japan			Abstract	
	AK	2000-512336	9/2000	Japan				
	AL	2000-512402	9/2000	Japan				
	AM	2002-033257	1/2002	Japan			Abstract	
ACW	AN	10-092740	4/1998	Japan			Abstract	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AP	
	AQ	

EXAMINER

J. C. W. W. W.

DATE CONSIDERED

July 23, 2004

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of form with next communication to applicant.

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: November 26, 2003

ATTY DOCKET NO.
2003_1698A

SERIAL NO.

NEW

10/721164

APPLICANT
Etsuko NAKAMURA et al.FILING DATE
November 26, 2003

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ACW	AA	6,329,118	12/2001	Hussein et al.			
ACW	AB	5,981,145	11/1999	Ding et al.			
ACW	AC	5,994,430	11/1999	Ding et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
ACW	AJ	10-319601	12/1998	Japan			Abstract	
	AK	2000-512336	9/2000	Japan				
	AL	2000-512402	9/2000	Japan				
↓	AM	2002-033257	1/2002	Japan			Abstract	
ACW	AN	10-092740	4/1998	Japan			Abstract	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AQ	
	AQ	

EXAMINER

JnC. Nakamura

DATE CONSIDERED

July 23, 2004